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Supplementary Information

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An electrode design rule for top-illuminated organic photovoltaics

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Method for calculating HOMO and LUMO levels:

To calculate the HOMO and LUMO levels from differential pulsed voltammetry the equations shown below were applied to the measured oxidation and reduction potentials to give the HOMO and LUMO respectively:

$$HOMO = -1.2 \times \left(1^{st} \ Oxidation \ E_{\frac{1}{2}Material} - E_{\frac{1}{2}Ferrocene}\right) - 4.8$$

$$LUMO = -1.2 \times \left(1^{st} Reduction E_{\frac{1}{2}Material} - E_{\frac{1}{2}Ferrocene}\right) - 4.8$$

Material	HOMO/ eV	LUMO/ eV
PC ₆₀ BM	-6.16	-3.78
PC ₇₀ BM	-6.05	-3.77

For both $PC_{60}BM$ and $PC_{70}BM$ the measured values are within the range reported in the literature using other measurement techniques.¹⁻¹⁰

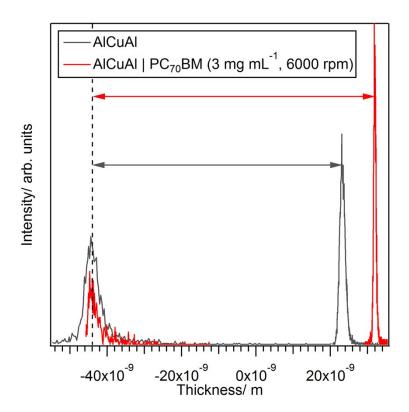


Figure S1: Step heights of AlCuAl and AlCuAl | $PC_{70}BM$ films measured using atomic force microscopy, showing how the organic semiconductor film thickness was determined. In this case the $PC_{70}BM$ solution concentration was 3 mg mL⁻¹, the spin speed was 6000 rpm and the film thickness was determined to be ~ 9 nm.

References

- 1. Davis et al., J. Mater. Chem., 2011, 21, 1721.
- 2. Scharber et al. Adv. Mater., 2006, 18(6), 789.
- 3. Yoo et al., Nanoscale. Res. Lett., 2011, 6, 545.
- 4. Guan et al., Org. Electron., 2010, 11(11), 1779.
- 5. Petoukhoff et al., Sol. Energ. Mat. Sol. Cells, 2014, 120, 72.
- 6. Thompson et al., Angew. Chem. Int. Ed. 2007, 47(1), 58.
- 7. Ratcliff et al., Org. Electron. 2012, 13(5), 744.
- 8. He et al., Chem. Commun., 2012, 48, 7616.
- 9. Singh et al., Adv. Func. Mater., 2012, 22(19), 4087.
- 10. Dou et al., Nature Photonics, 2012, 6, 180.